

<b>Notice of References Cited</b>	Application/Control No. 10/718,642		Applicant(s)/Patent Under Reexamination LEUNG ET AL.	
	Examiner TUYETLIEN T. TRAN		Art Unit 2179	Page 1 of 1

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#### NON-PATENT DOCUMENTS

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	U	BIB data sheet for 10240503
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